

INTERNATIONAL STANDARD

NORME INTERNATIONALE

End-face image analysis procedure for the calibration of optical fibre geometry test sets

Procédure d'analyse d'image d'extrémité pour l'étalonnage de dispositifs d'essais de géométrie des fibres optiques





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**END-FACE IMAGE ANALYSIS PROCEDURE FOR THE CALIBRATION
OF OPTICAL FIBRE GEOMETRY TEST SETS**

FOREWORD

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International Standard IEC 61745 has been prepared by IEC technical committee 86: Fibre optics.

This second edition cancels and replaces the first edition, published in 1998, and constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) removal of the limitation of single mode optical fibre geometry test sets to include multimode;
- b) addition of a new annex as mathematical basis.

The text of this International Standard is based on the following documents:

CDV	Report on voting
86/510/CDV	86/516/RVC

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

INTRODUCTION

In the research and production environments, there exists a range of test methods for characterizing the geometry of optical fibres. Furthermore, each test method may determine one or more of the many parameters required for complete geometrical characterization. IEC 61745 describes the calibration of test sets that perform end-face image analysis, also known as "near-field" or "grey-scale" analysis. The principles, however, may be applied to test sets of a different type.

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END-FACE IMAGE ANALYSIS PROCEDURE FOR THE CALIBRATION OF OPTICAL FIBRE GEOMETRY TEST SETS

1 Scope

This document describes the calibration of test sets that perform end-face image analysis, also known as "near-field" or "grey-scale" analysis. The principles, however, can be applied to test sets of a different type.

The procedures outlined are performed by calibration laboratories and by the manufacturers or users of geometry test sets, for the purpose of calibrating geometry test sets and for evaluating the uncertainties in measurements made on calibrated test sets. The calibration of fibre coating or cable measurement test sets is not covered by this document.

2 Normative references

There are no normative references in this document.

3 Terms and definitions

For the purpose of this International Standard, the following definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

3.1

accredited calibration laboratory

calibration laboratory authorized by an appropriate national organization to issue calibration certificates that demonstrate traceability to national standards

3.2

artefact

object that is measured on or used to calibrate a geometry test set

EXAMPLE An optical fibre and a chromium-on-glass pattern are examples of artefacts.

3.3

calibration

set of operations that establish, under specified conditions, the relationship between the values of quantities indicated by a measuring instrument and the corresponding values realized by standards

Note 1 to entry: The results of a calibration permit either the assignment of measurand values to the indications or the determination of corrections with respect to the indications.

Note 2 to entry: A calibration may also determine other metrological properties such as the effects of influence quantities.

Note 3 to entry: The result of a calibration may be recorded in a document, called a "calibration certificate" or a "calibration report".